

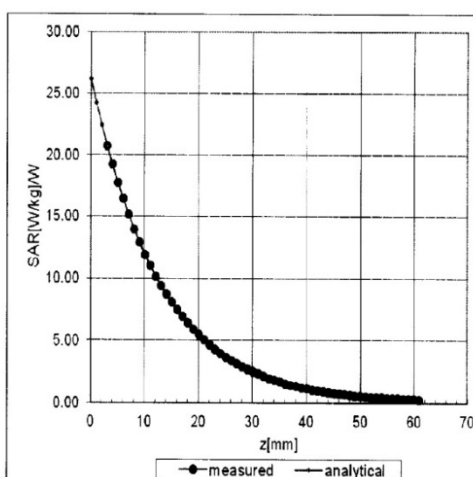
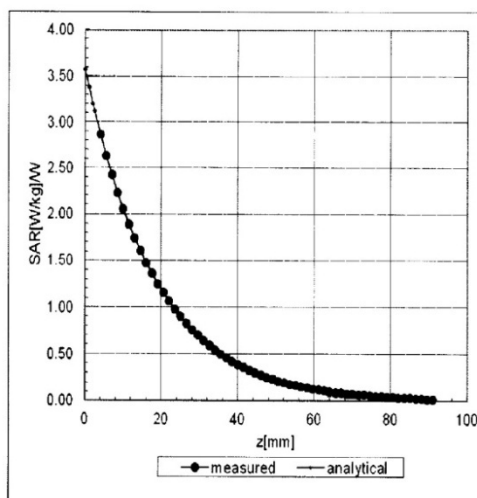


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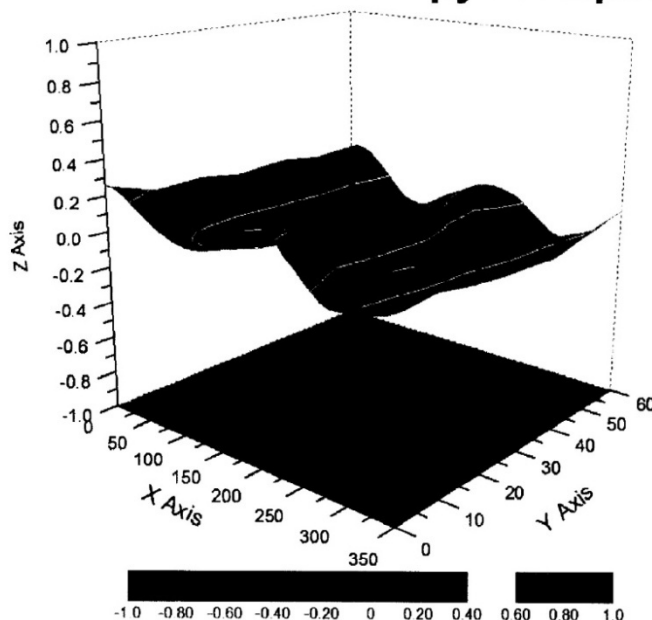
Conversion Factor Assessment

f=900 MHz, WGLS R9(H_convF)

f=1750 MHz, WGLS R22(H_convF)



Deviation from Isotropy in Liquid



Uncertainty of Spherical Isotropy Assessment: $\pm 3.2\%$ (K=2)



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CALIBRATION LABORATORY

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	156.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm



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IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

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TN_BR040315AD DAE4.doc

11.12.2009

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Accreditation No.: SCS 0108

Client **Anbotek (Auden)**

Certificate No: DAE4-387_Sep10

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BM - SN: 387**

Calibration procedure(s) **QA CAL-06.v29**
 Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **September 06, 2022**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-22 (No:21092)	Aug-23
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	05-Jan-22 (in house check)	In house check: Jan-23
Calibrator Box V2.1	SE UMS 006 AA 1002	05-Jan-22 (in house check)	In house check: Jan-23

Calibrated by: **Name** Dominique Steffen **Function** Laboratory Technician **Signature**

Approved by: **Sven Kühn** Deputy Manager

Issued: September 06, 2021

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Certificate No: DAE4-387_Sep10

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Accreditation No.: **SCS 0108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.489 \pm 0.02% (k=2)	404.852 \pm 0.02% (k=2)	404.862 \pm 0.02% (k=2)
Low Range	3.97827 \pm 1.50% (k=2)	3.95875 \pm 1.50% (k=2)	3.97982 \pm 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	53.0 ° \pm 1 °
---	------------------

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200032.85	-3.31	-0.00
Channel X + Input	20007.64	1.88	0.01
Channel X - Input	-20003.48	1.18	-0.01
Channel Y + Input	200034.23	-1.43	-0.00
Channel Y + Input	20006.60	0.91	0.00
Channel Y - Input	-20004.04	0.72	-0.00
Channel Z + Input	200035.38	-0.83	-0.00
Channel Z + Input	20003.69	-2.11	-0.01
Channel Z - Input	-20006.38	-1.59	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.63	0.08	0.00
Channel X + Input	202.29	0.70	0.35
Channel X - Input	-197.90	0.60	-0.30
Channel Y + Input	2001.33	-0.07	-0.00
Channel Y + Input	200.86	-0.60	-0.30
Channel Y - Input	-199.87	-1.23	0.62
Channel Z + Input	2001.61	0.27	0.01
Channel Z + Input	200.60	-0.70	-0.35
Channel Z - Input	-199.51	-0.85	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-1.70	0.33
Channel Y	200	10.70	-	-0.38
Channel Z	200	7.11	7.89	-



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

5. Input Offset MeasurementDASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (k Ω m)	Measuring (M Ω m)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Multilateral Agreement for the recognition of calibration certificates

Client **Anbotek (Auden)**

Certificate No: **D5GHzV2-1160_Oct11**

CALIBRATION CERTIFICATE

Object **D5GHzV2 - SN: 1160**

Calibration procedure(s) **QA CAL-22.v2**
Calibration procedure for dipole validation kits between 3-6 GHz

Calibration date: **October 02, 2021**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	07-Oct-17 (No. 217-02020)	Oct-15
Power sensor HP 8481A	US37292783	07-Oct-20 (No. 217-02020)	Oct-15
Power sensor HP 8481A	MY41092317	07-Oct-20 (No. 217-02021)	Oct-15
Reference 20 dB Attenuator	SN: 5058 (20k)	01-Apr-21 (No. 217-02131)	Mar-16
Type-N mismatch combination	SN: 5047.2 / 06327	01-Apr-21 (No. 217-02134)	Mar-16
Reference Probe EX3DV4	SN: 3503	30-Dec-20 (No. EX3-3503_Dec14)	Dec-15
DAE4	SN: 601	17-Aug-21 (No. DAE4-601_Aug15)	Aug-16
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator R&S SMT-06	100972	18-Jun-21 (in house check Jun-15)	In house check: Jun-18
Network Analyzer HP 8753E	US37390585 S4206	15-Oct-20 (in house check Oct-14)	In house check: Oct-15

Calibrated by: **Name** **Leif Klysner** **Function** **Laboratory Technician**

Approved by: **Katja Pokovic** **Technical Manager**

Signature

Issued: October 6, 2021

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Certificate No: D5GHzV2-1160_Oct11

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 1.4 mm	Graded Ratio = 1.4 (Z direction)
Frequency	5200 MHz \pm 1 MHz 5300 MHz \pm 1 MHz 5600 MHz \pm 1 MHz 5800 MHz \pm 1 MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 \pm 0.2) °C	36.4 \pm 6 %	4.57 mho/m \pm 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	80.7 W/kg \pm 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.31 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.1 W/kg \pm 19.5 % (k=2)

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Head TSL parameters at 5300 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.9	4.76 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	36.2 ± 6 %	4.68 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.26 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.7 W / kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.39 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.9 W/kg ± 19.5 % (k=2)

Head TSL parameters at 5600 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.5	5.07 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.7 ± 6 %	5.03 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.69 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	87.0 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.47 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.7 W/kg ± 19.5 % (k=2)

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Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.3 ± 6 %	5.26 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.20 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.0 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.31 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.1 W/kg ± 19.5 % (k=2)

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Body TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	49.0	5.30 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.9 ± 6 %	5.35 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.81 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	77.8 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.18 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	21.7 W/kg ± 19.5 % (k=2)

Body TSL parameters at 5300 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.9	5.42 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.7 ± 6 %	5.49 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.4 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	21.9 W/kg ± 19.5 % (k=2)

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Body TSL parameters at 5600 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.5	5.77 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	46.7 ± 6 %	5.99 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	8.20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	81.5 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.30 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	22.8 W/kg ± 19.5 % (k=2)

Body TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.2	6.00 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	46.4 ± 6 %	6.27 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.3 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	21.8 W/kg ± 19.5 % (k=2)

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Appendix (Additional assessments outside the scope of SCS 0108)**Antenna Parameters with Head TSL at 5200 MHz**

Impedance, transformed to feed point	48.1 Ω - 8.5 j Ω
Return Loss	- 21.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance, transformed to feed point	50.2 Ω - 5.2 j Ω
Return Loss	- 25.7 dB

Antenna Parameters with Head TSL at 5600 MHz

Impedance, transformed to feed point	54.8 Ω - 2.5 j Ω
Return Loss	- 25.7 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	53.0 Ω - 3.0 j Ω
Return Loss	- 27.7 dB